MOSFET – Power, Single, N-Channel, DPAK/IPAK 30 V, 88 A

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- NVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

Applications

- CPU Power Delivery
- DC-DC Converters
- Low Side Switching

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltag	V _{DSS}	30	V		
Gate-to-Source Voltage	Gate-to-Source Voltage				V
Continuous Drain		T _A = 25°C	I _D	17.4	Α
Current (R _{θJA}) (Note 1)		T _A = 85°C		13.5	
Power Dissipation $(R_{\theta JA})$ (Note 1)		T _A = 25°C	P _D	2.65	W
Continuous Drain	1	T _A = 25°C	I _D	12.7	Α
Current (R _{θJA}) (Note 2)	Steady	T _A = 85°C		9.8	
Power Dissipation $(R_{\theta JA})$ (Note 2)	State	T _A = 25°C	P _D	1.41	W
Continuous Drain]	T _C = 25°C	I _D	95	Α
Current (R _{θJC}) (Note 1)		T _C = 85°C		73	
Power Dissipation ($R_{\theta JC}$) (Note 1)		T _C = 25°C	P _D	79	W
Pulsed Drain Current	t _p =10μs	T _A = 25°C	I _{DM}	175	Α
Current Limited by Pack	age	T _A = 25°C	I _{DmaxPkg}	45	Α
Operating Junction and	Storage Te	mperature	T _J , T _{stg}	-55 to 175	°C
Source Current (Body Di	iode)		I _S	55	Α
Source Current (Body Di	I _{SM}	175	Α		
Drain to Source dV/dt	dV/dt	6.0	V/ns		
Single Pulse Drain-to-Source Avalanche Energy (V_{DD} = 24 V, V_{GS} = 10 V, L = 1.0 mH, $I_{L(pk)}$ = 24 A, R_G = 25 Ω)			E _{AS}	288	mJ
Lead Temperature for So (1/8" from case for 10 s)	Lead Temperature for Soldering Purposes			260	°C

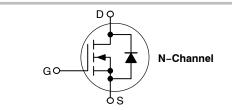
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
30 V	5.0 mΩ @ 10 V	88 A
	7.4 mΩ @ 4.5 V	00 A



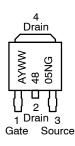


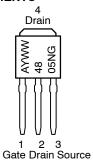
DPAK CASE 369AA (Bent Lead) STYLE 2



IPAK
CASE 369D
(Straight Lead DPAK)
STYLE 2

MARKING DIAGRAMS & PIN ASSIGNMENTS





A = Assembly Location*

Y = Year
WW = Work Week
4805N = Device Code
G = Pb-Free Package

* The Assembly Location code (A) is front side optional. In cases where the Assembly Location is stamped in the package, the front side assembly code may be blank.

ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ hetaJC}$	1.9	°C/W
Junction-to-TAB (Drain)	$R_{ heta JC-TAB}$	3.5	
Junction-to-Ambient - Steady State (Note 1)	$R_{ heta JA}$	56.6	
Junction-to-Ambient - Steady State (Note 2)	$R_{ heta JA}$	106.6	

Parameter	Symbol	Test Co	ndition	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•		<u>'</u>		•	•	·
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				27		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 24 \text{ V}$ $T_{J} = 25^{\circ}\text{C}$ $T_{J} = 125^{\circ}\text{C}$				1.0	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V	_			±100	nA
ON CHARACTERISTICS (Note 3)					1	I	<u> </u>
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$	l _D = 250 μA	1.5		2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				5.86		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 to	I _D = 30 A		4.3	5.0	mΩ
		11.5 V	I _D = 15 A		4.2		1
		V _{GS} = 4.5 V	I _D = 30 A		6.0	7.4	
			I _D = 15 A		5.8		1
Forward Transconductance	9 _{FS}	V _{DS} = 15 V, I _D = 15 A			17		S
CHARGES AND CAPACITANCES	•				•		<u> </u>
Input Capacitance	C _{iss}				2865		pF
Output Capacitance	C _{oss}	$V_{GS} = 0 \text{ V, f}$ $V_{DS} =$			610		
Reverse Transfer Capacitance	C _{rss}	*DS =	'- v		338		
Total Gate Charge	Q _{G(TOT)}				20.5	26	nC
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 4.5 V,	V _{DS} = 15 V,		4.05		
Gate-to-Source Charge	Q_{GS}	I _D = 3			8.28		1
Gate-to-Drain Charge	Q_GD		•		8.36		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 11.5 V,			48		nC
SWITCHING CHARACTERISTICS (Note 4)							
Turn-On Delay Time	t _{d(on)}				17.2		ns
Rise Time	t _r	V _{GS} = 4.5 V,	V _{DS} = 15 V,		20.3		
Turn-Off Delay Time	t _{d(off)}	$I_D = 15 \text{ A}, R_G = 3.0 \Omega$			20.8		
Fall Time	t _f				8.0		
Turn-On Delay Time	t _{d(on)}				10.8		ns
Rise Time	t _r	V _{GS} = 11.5 V,	V _{DS} = 15 V,		20.5		
Turn-Off Delay Time	t _{d(off)}	I _D = 15 A, F			30.8		
Fall Time	t _f		•		4.4		

Surface-mounted on FR4 board using 1 in sq pad size, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted) (continued)

Parameter	Symbol	Test Co	Test Condition		Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACT	ERISTICS						
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$		0.87	1.2	V
			T _J = 125°C		0.76		
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dls/dt = 100 A/μs, l _S = 30 A			25.7		ns
Charge Time	ta				13.1		1
Discharge Time	tb				12.6		1
Reverse Recovery Time	Q _{RR}				18		nC
PACKAGE PARASITIC VALUES	-						-
Source Inductance	L _S				2.49		nΗ
Drain Inductance, DPAK	L _D				0.0164		1
Drain Inductance, IPAK	L _D	T _A = 25°C			1.88		1
Gate Inductance	L _G				3.46		1
Gate Resistance	R_{G}	1			0.8		Ω

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Pulse Test: Pulse Width ≤ 300 µs, Duty Cycle ≤ 2%.

4. Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES

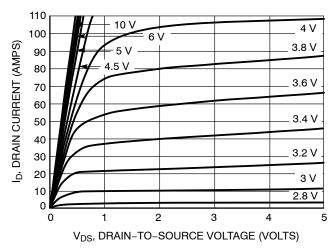


Figure 1. On-Region Characteristics

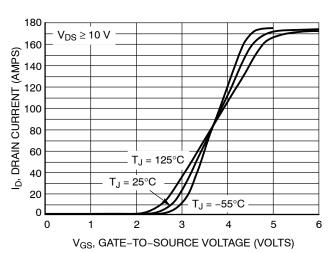


Figure 2. Transfer Characteristics

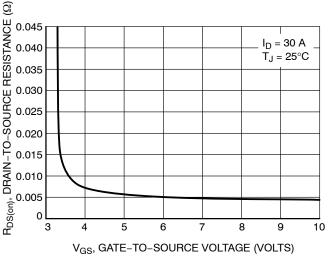


Figure 3. On–Resistance vs. Gate–to–Source Voltage

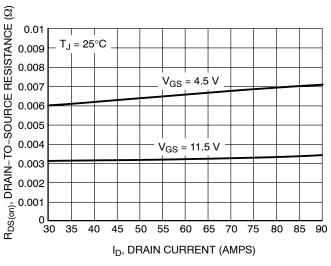


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

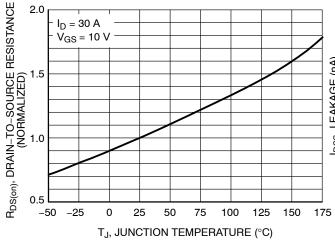


Figure 5. On–Resistance Variation with Temperature

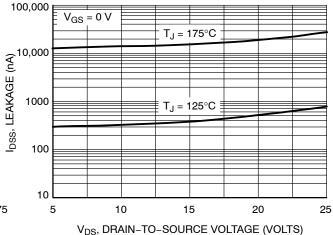
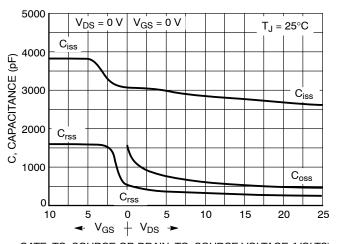


Figure 6. Drain-to-Source Leakage Current vs. Drain Voltage

TYPICAL PERFORMANCE CURVES



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

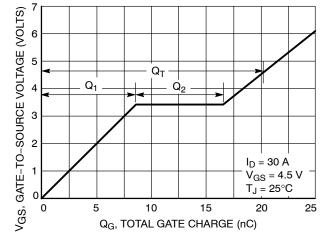


Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge



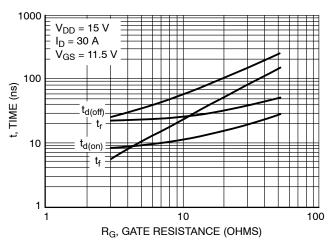


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

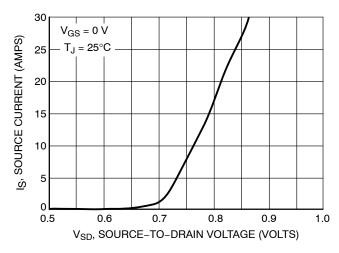


Figure 10. Diode Forward Voltage vs. Current

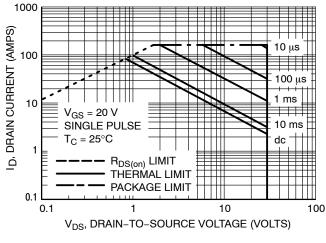


Figure 11. Maximum Rated Forward Biased Safe Operating Area

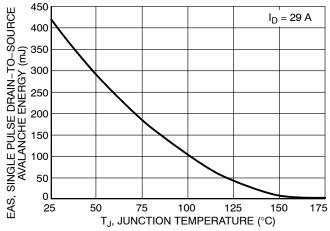


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL PERFORMANCE CURVES

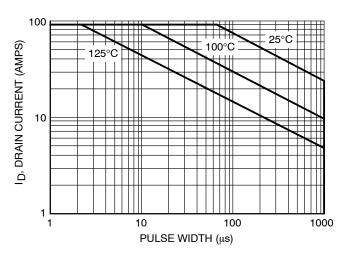


Figure 13. Avalanche Characteristics

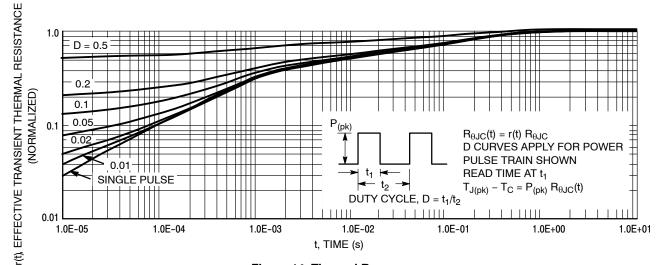


Figure 14. Thermal Response

ORDERING INFORMATION

Order Number	Package	Shipping [†]
NTD4805NT4G	DPAK (Pb-Free)	2,500 / Tape & Reel
NTD4805N-1G	IPAK (Pb-Free)	75 Units / Rail
NVD4805NT4G*	DPAK (Pb-Free)	2,500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

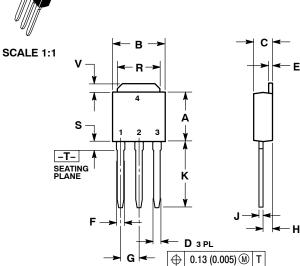
^{*}NVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable.

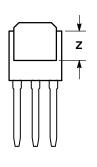
MECHANICAL CASE OUTLINE





DATE 15 DEC 2010





NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
E	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090	BSC	2.29 BSC	
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
V	0.035	0.050	0.89	1.27
Z	0.155		3.93	

MARKING DIAGRAMS

1:	s
BASE	
COLLECTOR	
EMITTER	
COLLECTOR	
	BASE COLLECTOR EMITTER

STYLE 5: PIN 1. GATE

2. ANODE CATHODE

ANODE

STYLE 2: PIN 1. GATE 2. DRAIN SOURCE 3 DRAIN

STYLE 6: PIN 1. MT1 2. MT2 3. GATE

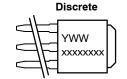
MT2

STYLE 3: PIN 1. ANODE 2. CATHODE 3 ANODE 4. CATHODE

STYLE 7: PIN 1. GATE 2. COLLECTOR

3. EMITTER COLLECTOR STYLE 4: PIN 1. CATHODE ANODE
 GATE

4. ANODE



WW

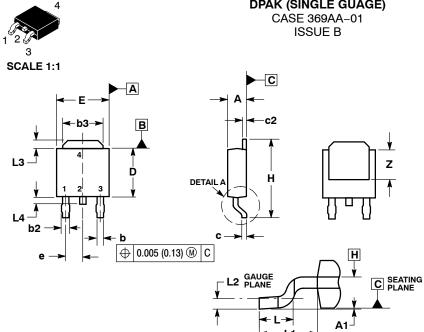


xxxxxxxxx = Device Code Α = Assembly Location IL = Wafer Lot Υ = Year

= Work Week

DOCUMENT NUMBER:	98AON10528D	Electronic versions are uncontrolled except when accessed directly from the Document Reposito Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.			
DESCRIPTION:	IPAK (DPAK INSERTION M	IOUNT)	PAGE 1 OF 1		

ON Semiconductor and (III) are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.





DETAIL A ROTATED 90° CW **DATE 03 JUN 2010**

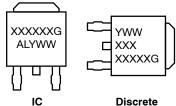
NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: INCHES.
 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD
- FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE
- DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

	INC	HES	MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.030	0.045	0.76	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
E	0.250	0.265	6.35	6.73
е	0.090	BSC	2.29 BSC	
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.108	REF	2.74	REF
L2	0.020 BSC		0.51	BSC
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	

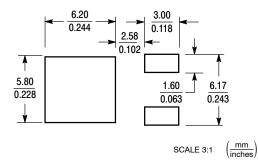
STYLE 4: PIN 1. CATHODE 2. ANODE 3. GATE STYLE 1: PIN 1. BASE STYLE 2: PIN 1. GATE STYLE 3: PIN 1. ANODE 2. COLLECTOR 3. EMITTER 2. CATHODE 3. ANODE 2. DRAIN 3. SOURCE 4. COLLECTOR 4. DRAIN CATHODE STYLE 5: STYLE 6: STYLE 7: PIN 1. GATE 2. ANODE 3. CATHODE PIN 1. GATE 2. COLLECTOR PIN 1. MT1 2. MT2 3. GATE 3. EMITTER 4. ANODE COLLECTOR

GENERIC MARKING DIAGRAM*



XXXXXX = Device Code Α = Assembly Location L = Wafer Lot ٧ = Year = Work Week WW = Pb-Free Package

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

DOCUMENT NUMBER:	98AON13126D	Electronic versions are uncontrolled except when accessed directly from the Document Reposit Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	DPAK (SINGLE GAUGE)		PAGE 1 OF 1	

ON Semiconductor and un are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others

^{*}This information is generic. Please refer to device data sheet for actual part marking.

onsemi, ONSEMi., and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any EDA class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer p

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT: Email Requests to: orderlit@onsemi.com

onsemi Website: www.onsemi.com

TECHNICAL SUPPORT North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative